









SN74AHC595-Q1

SCLS537E - AUGUST 2003 - REVISED APRIL 2024

SN74AHC595-Q1 Automotive 8-Bit Shift Register With 3-State Output Registers

1 Features

- Qualified for automotive applications
- Operating range 2V to 5.5V V_{CC}
- 8-bit serial-in, parallel-out shift
- Shift register has direct clear

2 Applications

- Enable or disable a digital signal
- Controlling an indicator LED
- Translation between communication modules and system controllers

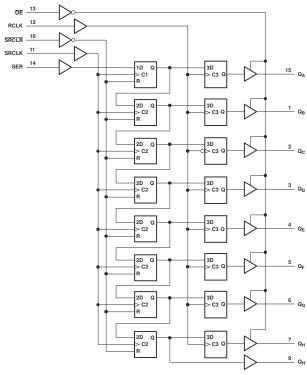
3 Description

The SN74AHC595 contains an 8-bit serial-in, parallelout shift register that feeds an 8-bit D-type storage register.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE(2)	BODY SIZE(3)
SN74AHC595-Q1	BQB (WQFN, 16)	3.5mm × 2.5mm	3.5mm × 2.5mm
31174A110393-Q1	PW (TSSOP, 16)	5.00mm × 6.40mm	5.00mm × 4.4mm

- For more information, see Section 11. (1)
- (2)The package size (length x width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.



Logic Diagram (Positive Logic)

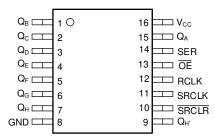


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4 Pin Configuration and Functions



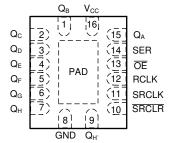


Figure 4-1. PW Package, 16-PIN TSSOP (Top View)

Figure 4-2. BQB Package, 16-Pin WQFN (Top View)

Table 4-1. Pin Functions

	PIN		
NAME	NO.	TYPE ⁽¹⁾	DESCRIPTION
Q _B	1	0	Q _B Output
Q _C	2	0	Q _C Output
Q_D	3	0	Q _D Output
Q _E	4	0	Q _E Output
Q _F	5	0	Q _F Output
Q_G	6	0	Q _G Output
Q _H	7	0	Q _H Output
GND	8	G	Ground Pin
Q _H	9	0	Q _H Output
SRCLR	10	I	SRCLR Input
SRCLK	11	I	SRCLK Input
RCLK	12	I	RCLK Input
ŌĒ	13	I	Output Enable Pin. Active LOW
SER	14	I	SER Input
Q _A	15	0	Q _A Output
V _{CC}	16	Р	Power Pin

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
VI	Input voltage range ⁽²⁾		-0.5	7	V
Vo	Output voltage range ⁽²⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	(V ₁ < 0)		–20 mA	mA
I _{OK}	Output clamp current	$(V_O < 0 \text{ or } V_O > V_{CC})$		±20 mA	mA
Io	Continuous output current	$(V_O = 0 \text{ to } V_{CC})$		±25 mA	mA
	Continuous current through V _{CC} or GND			±75 mA	mA
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 Recommended Operating Conditions

over recommended operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		2	5.5	V
		V _{CC} = 2 V	1.5		
V_{IH}	High-level input voltage	V _{CC} = 3 V	2.1		V
		V _{CC} = 5.5 V	3.85		
		V _{CC} = 2 V		0.5	
V_{IL}	Low-level input voltage	V _{CC} = 3 V		0.9	V
		V _{CC} = 5.5 V		1.65	
VI	Input voltage	· · · · · · · · ·		5.5	V
Vo	Output voltage		0	V _{CC}	V
		V _{CC} = 2 V		-50	μA
I_{OH}	H High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		-4	^
		$V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$		-8	mA
		V _{CC} = 2 V		50	μΑ
I_{OL}	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		4	A
		V _{CC} = 5 V ± 0.5 V		8	mA
۸4/۸۰۰	Input transition rice or fall rate	V _{CC} = 3.3 V ± 0.3 V		100	no/\/
ΔυΔν	t/∆v Input transition rise or fall rate	$V_{CC} = 5 V \pm 0.5 V$		20	ns/V
т	Operating free air temperature	I-suffix devices	-40	85	°C
T _A O	Operating free-air temperature	Q-suffix devices	-40	125	C

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

5.3 Thermal Information

THERMAL METRIC ⁽¹⁾		BQB (WQFN)	PW (TSSOP)	UNIT
		16 PINS	16 PINS	ONII
$R_{\theta JA}$	Junction-to-ambient thermal resistance	91.8	135.9	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

Product Folder Links: SN74AHC595-Q1

⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



5.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	TA	= 25°C		MIN MAX	MAY	UNIT
PARAIVIETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	IVIIIN	IVIAA	UNIT
		2 V	1.9	2		1.9		
	$I_{OH} = -50 \mu A$	3 V	2.9	3		2.9		
V _{OH}		4.5 V	4.4	4.5		4.4		V
	I _{OH} = -4 mA	3 V	2.58			2.48		
	I _{OH} = -8 mA	4.5 V	3.94			3.8		
		2 V			0.1		0.1	
	I _{OL} = 50 μA	3 V			0.1		0.1	
V _{OL}		4.5 V			0.1		0.1	V
	I _{OL} = 4 mA	3 V			0.36		0.44	
	I _{OL} = 8 mA	4.5 V			0.36		0.44	
I _I	V _I = 5.5 V or GND	0 V to 5.5 V			±0.1		±1	μA
loz	Q_A-Q_H , $V_I = V_{CC}$ or GND, $V_O = V_{CC}$ or GND, $\overline{OE} = V_{IH}$ or V_{IL}	5.5 V			±0.25		±10	μA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V			4		40	μΑ
C _i	V _I = V _{CC} or GND	5 V		3	10		10	pF
Co	V _O = V _{CC} or GND	5 V		5.5				pF

5.5 Timing Requirements, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

 V_{CC} = 3.3 V ± 0.3 V, over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

	<u>, </u>		T _A = 2	5°C	MIN MA		UNIT	
			MIN	MAX	IVIIIN	WAA	UNIT	
		SRCLK high or low	5.5		6.5			
t _w		RCLK high or low	5.5		6.5		ns	
		SRCLR low	5		6			
		SER before SRCLK↑	3.5		4.5			
	Setup time	SRCLK↑ before RCLK↑ ⁽¹⁾	8		9.5		20	
t _{su}	Setup time	SRCLR low before RCLK↑	8		10		ns	
		SRCLR high (inactive) before SRCLK↑	3		4			
t _h	Hold time	SER after SRCLK↑	1.5		2.5		ns	

⁽¹⁾ This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

5.6 Timing Requirements, $V_{CC} = 5 V \pm 0.5 V$

 V_{CC} = 5 V ± 0.5 V, over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

			T _A = 2	5°C	MIN	MAX	UNIT
			MIN	MAX	IVIIN	WAX	UNII
	SRCLK high or low	5		6			
t _w	t _w Pulse duration	RCLK high or low	5		6		ns
		SRCLR low	5.2		6.2		

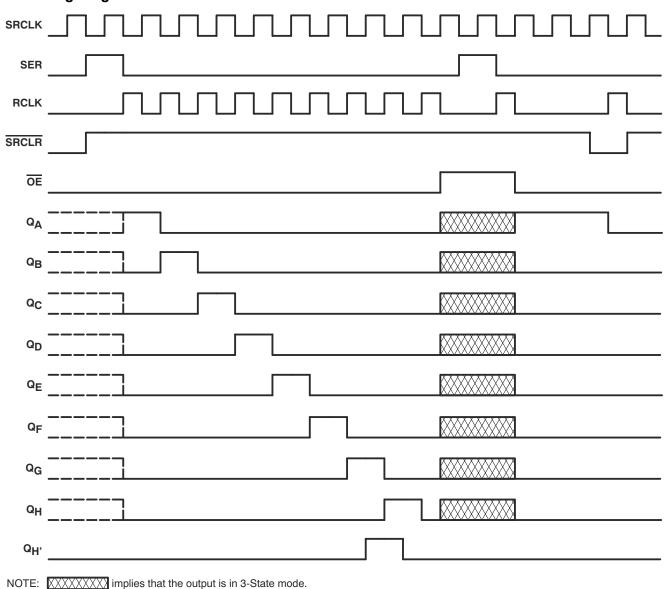


 $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$, over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

			T _A = 2	T _A = 25°C		MAX	UNIT
			MIN	MAX	MIN	WAA	UNII
	SER before SRCLK↑	3		4			
	t _{su} Setup time	SRCLK↑ before RCLK↑ ⁽¹⁾	5		6		
Lsu		SRCLR low before RCLK↑	5		6		ns
		SRCLR high (inactive) before SRCLK↑	2.5		3.5		
t _h	Hold time	SER after SRCLK↑	2		3		ns

This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

5.7 Timing Diagrams



5.8 Switching Characteristics, V_{CC} = 3.3 V \pm 0.3 V

 V_{CC} = 3.3 V ± 0.3 V, over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM	то	LOAD	TA	= 25°C		MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	IVIIIN	IVIAA	UNIT
f _{max}			C _L = 50 pF	55	105		40		MHz
t _{PLH}	RCLK	Q_A – Q_H	C _L = 50 pF		7.9	15.4	1	20	ns
t _{PHL}	NOLK	$Q_A - Q_H$	CL = 30 pr		7.9	15.4	1	20	115
t _{PLH}	SRCLK	Q _H	C _L = 50 pF		9.2	16.5	1	21.5	ne
t _{PHL}	SKOLK				9.2	16.5	1	21.5	ns
t _{PHL}	SRCLR	Q _{H'}	C _L = 50 pF		9	16.3	1	20.2	ns
t _{PZH}	OE	Q _A –Q _H	C _L = 50 pF		7.8	15	1	20	ns
t _{PZL}) JL	VA [—] VH			9.6	15	1	20	115
t _{PHZ}	ŌĒ Q _A −Q _H	Q _A –Q _H	C = 50 pF		8.1	15.7	1	19.2	nc
t _{PLZ}		VA [—] VH	C _L = 50 pF		9.3	15.7	1	19.2	ns

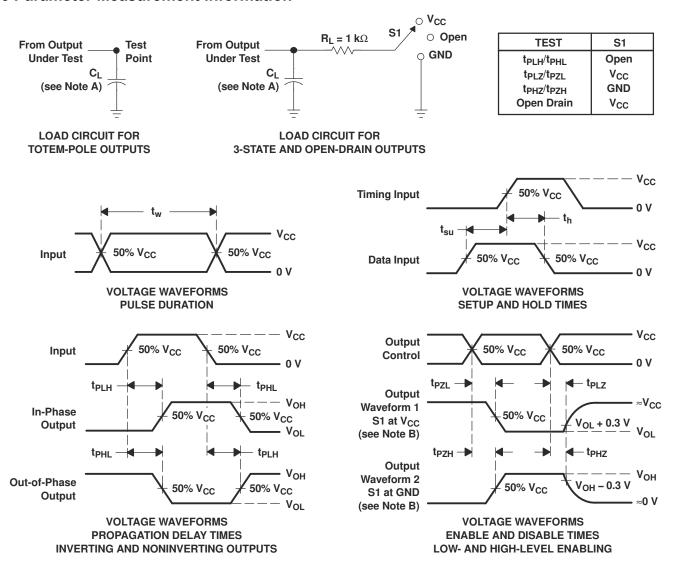
5.9 Switching Characteristics, V_{CC} = 5 V ± 0.5 V

 V_{CC} = 5 V ± 0.5 V, over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM	TO LOAD	LOAD	T _A = 25°C			MIN MAX	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	IVIIIN	IVIAA	UNIT
f _{max}			C _L = 50 pF	95	140		75		MHz
t _{PLH}	RCLK	0 0	C _L = 50 pF		5.6	9.4	1	13.5	no
t _{PHL}		Q _A –Q _H	CL = 50 pr		5.6	9.4	1	13.5	ns
t _{PLH}	SRCLK	0	C _L = 50 pF		6.4	10.2	1	14.4	ns
t _{PHL}		Q _H '	OL = 30 pi		6.4	10.2	1	14.4	115
t _{PHL}	SRCLR	Q _H	C _L = 50 pF		6.4	10	1	14.1	ns
t _{PZH}	ŌE.	0 0	C _L = 50 pF		5.7	10.6	1	15	no
t _{PZL}	ŌĒ	Q _A –Q _H			6.8	10.6	1	15	ns
t _{PHZ}	ŌĒ	00.	C _L = 50 pF		3.5	10.3	1	14	ns
t _{PLZ}	J	Q _A –Q _H	OL = 30 pr		3.4	10.3	1	14	115



6 Parameter Measurement Information



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.

Figure 6-1. Load Circuit and Voltage Waveforms

7 Detailed Description

7.1 Overview

The SN74AHC595 contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. The storage register has parallel 3-state outputs. Separate clocks are provided for both the shift and storage registers.

The shift register has a direct overriding clear (\overline{SRCLR}) input, serial (SER) input, and a serial output for cascading. When the output-enable (\overline{OE}) input is high, all outputs, except $Q_{H'}$, are in the high-impedance state.

Both the shift-register clock (SRCLK) and storage-register clock (RCLK) are positive-edge triggered. If both clocks are connected together, the shift register always is one clock pulse ahead of the storage register.

7.2 Functional Block Diagram

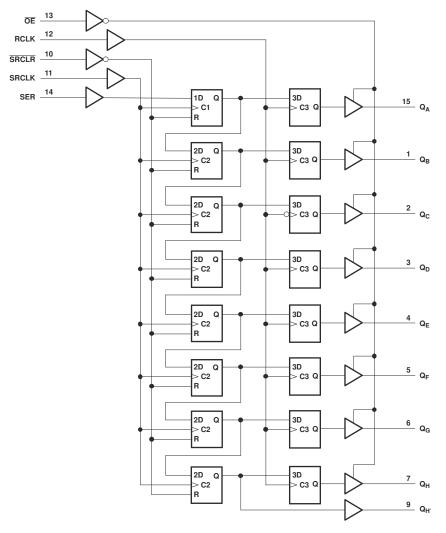


Figure 7-1. Logic Diagram (Positive Logic)



7.3 Device Functional Modes

Table 7-1. Function Table

		INPUTS			FUNCTION
SER	SRCLK	SRCLR	RCLK	ŌĒ	FUNCTION
Х	Х	Х	Х	Н	Outputs Q _A –Q _H are disabled.
X	Χ	Χ	Χ	L	Outputs Q _A –Q _H are enabled.
X	Χ	L	Χ	Χ	Shift register is cleared.
L	↑	Н	Х	Х	First stage of the shift register goes low. Other stages store the data of previous stage, respectively.
Н	↑	Н	Х	Х	First stage of the shift register goes high. Other stages store the data of previous stage, respectively.
Х	Х	Х	1	Х	Shift-register data is stored into the storage register.

8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in the following layout example.

8.2 Layout

8.2.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices, inputs must never be left floating. In many cases, functions or parts of functions of digital logic devices are unused (for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used). Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC}, whichever makes more sense for the logic function or is more convenient.

8.2.2 Layout Example

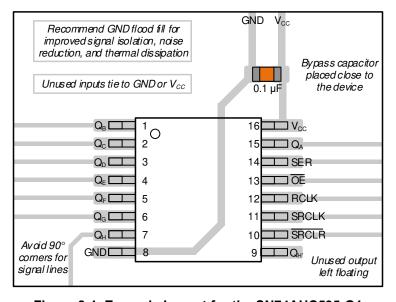


Figure 8-1. Example Layout for the SN74AHC595-Q1

9 Device and Documentation Support

9.1 Document Support (Analog)

9.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 9-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN74AHC595-Q1	Click here	Click here	Click here	Click here	Click here	

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

Submit Document Feedback

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (March 2024) to Revision E (April 2024)

Page

Changes from Revision C (November 2023) to Revision D (March 2024)

Page

Added BQB package to Package Information table, Pin Configuration and Functions section, and Thermal
 Information table

Product Folder Links: SN74AHC595-Q1



11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com

31-Oct-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
	('')	(2)			(0)	(4)	(5)		(0)
SN74AHC595QPWRQ1	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA595Q
SN74AHC595QPWRQ1.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA595Q
SN74AHC595QWBQBRQ1	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AH595Q
SN74AHC595QWBQBRQ1.A	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AH595Q

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74AHC595-Q1:

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

www.ti.com 31-Oct-2025

• Catalog : SN74AHC595

NOTE: Qualified Version Definitions:

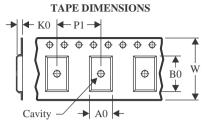
• Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Jul-2025

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHC595QPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC595QWBQBRQ1	WQFN	BQB	16	3000	180.0	12.4	2.8	3.8	1.2	4.0	12.0	Q1

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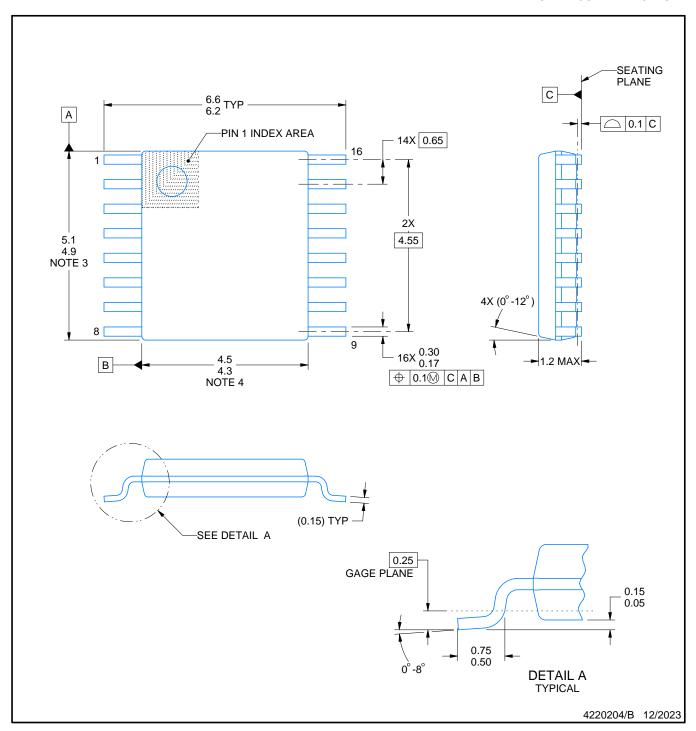


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHC595QPWRQ1	TSSOP	PW	16	2000	353.0	353.0	32.0
SN74AHC595QWBQBRQ1	WQFN	BQB	16	3000	210.0	185.0	35.0



SMALL OUTLINE PACKAGE



NOTES:

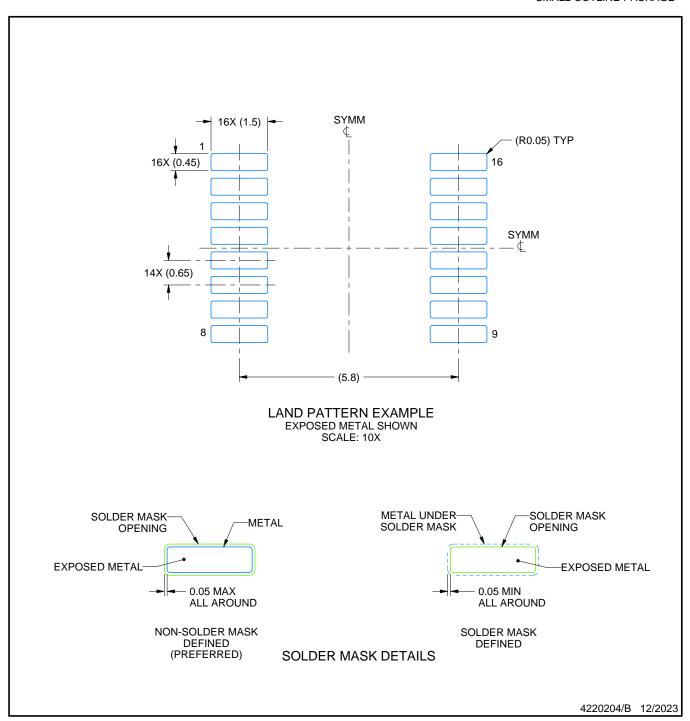
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE

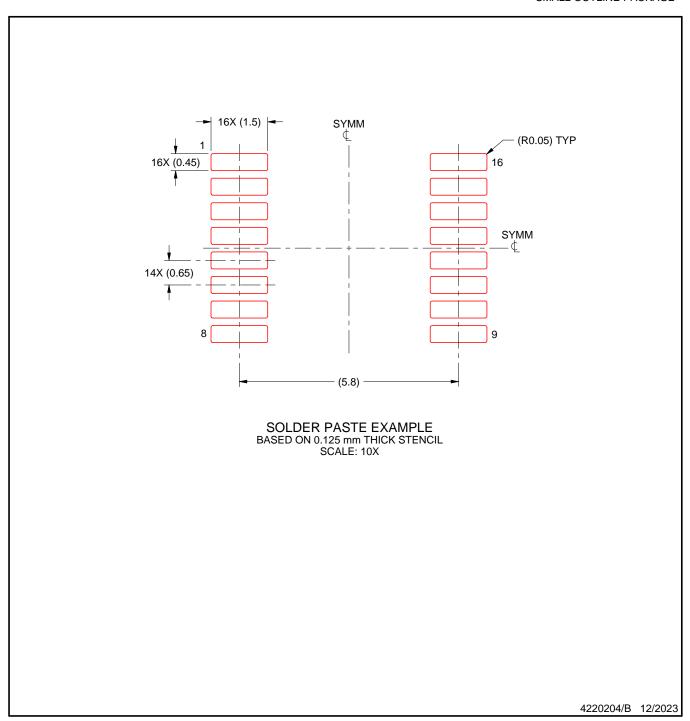


NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

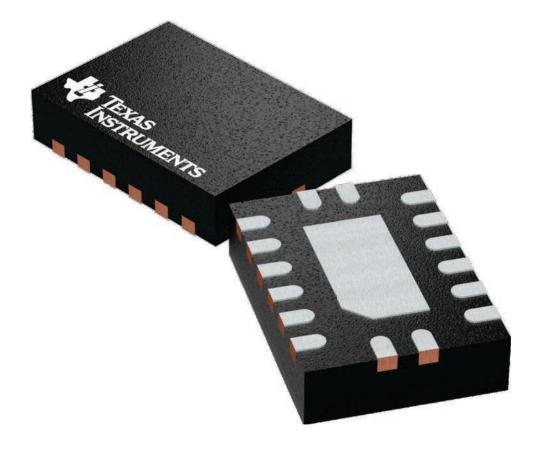
- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



2.5 x 3.5, 0.5 mm pitch

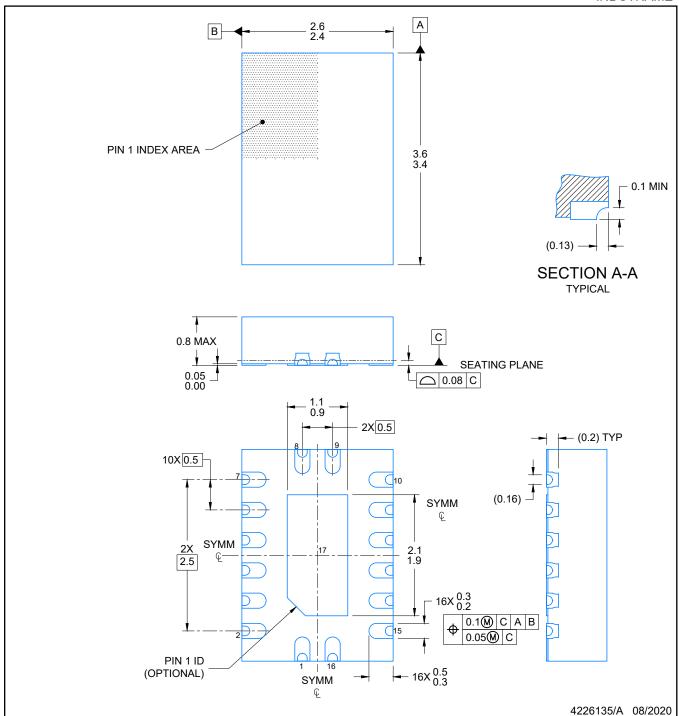
PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



INSTRUMENTS www.ti.com

INDSTNAME

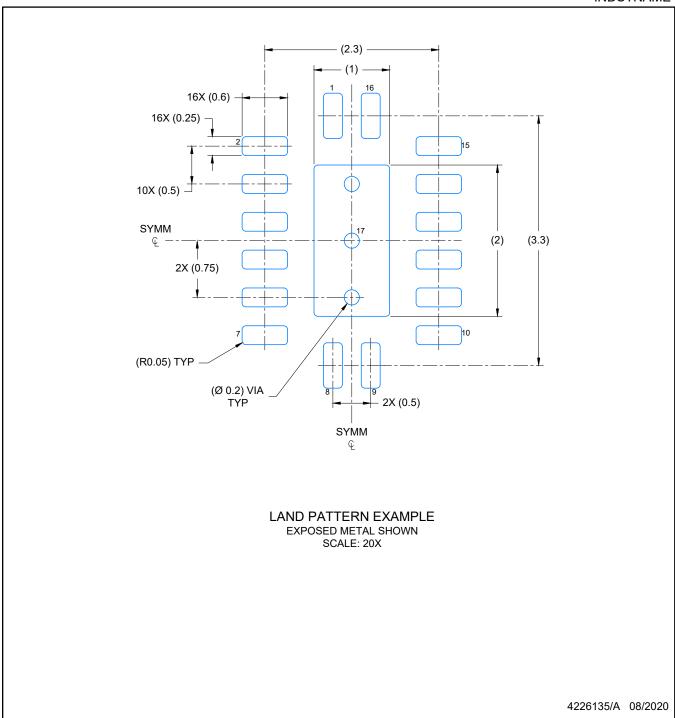


NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



INDSTNAME

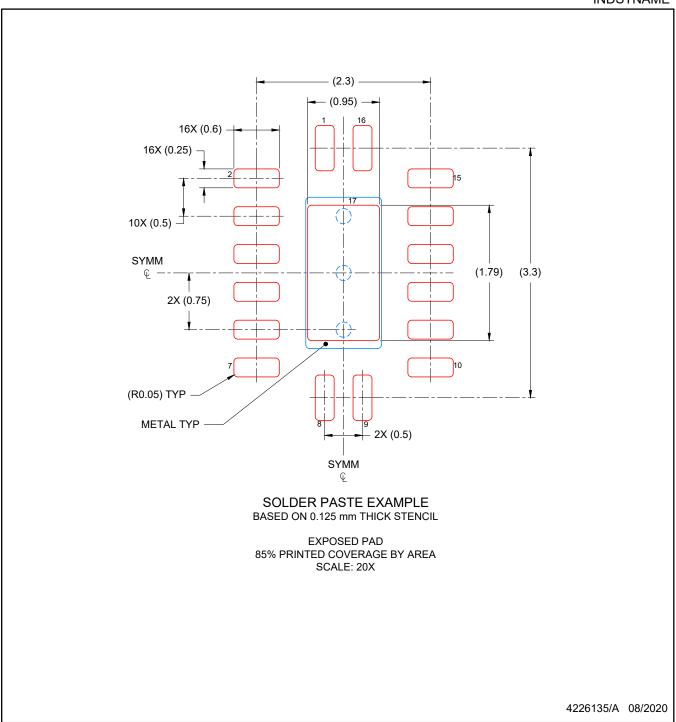


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



INDSTNAME



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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